


<b>Search Notes</b>  	<b>Application/Control No.</b>  10587531	<b>Applicant(s)/Patent Under Reexamination</b>  HEYDER, MARTIN
	<b>Examiner</b>  Desai, Naishadh N	<b>Art Unit</b>  2834

SEARCHED			
Class	Subclass	Date	Examiner
384	517		
384	518		

SEARCH NOTES		
Search Notes	Date	Examiner
310/14,84,87 and 90 with keywords	10/29/2007	NND
h02k\$.ipc with keywords	10/26/2007	NND
384 with key words	10/30/2007	NND
267 with keywords	10/30/2007	NND
several forward/backward citations	10/29/2007	NND
Consulted primary Burton Mullins for search and Dang Le	10/30/2007	NND

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner